

<b>Notice of References Cited</b>	Application/Control No. 10/757,302		Applicant(s)/Patent Under Reexamination HE ET AL.	
	Examiner KEATH T. CHEN		Art Unit 1716	Page 1 of 1

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*	C	US-6,996,550	02-2006	Wang et al.	706/19
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	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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